

Search Notes

Application/Control No.

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Examiner

Minh Dieu Nguyen

Applicant(s)/Patent under
Reexamination

LEWIS, CRAIG

Art Unit

2137

SEARCHED

Class	Subclass	Date	Examiner
713	184, 200, 202	7/14/2005	MDN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search on EAST (US-PAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB)	7/14/2005	MDN